

Substitute for form 1449A/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Application Number	10/761,667 – Conf. # 3419
				Filing Date	January 21, 2004
				First Named Inventor	Kenneth DONG
				Art Unit	2624
				Examiner Name	D. Rashid
Sheet	1	of	2	Attorney Docket Number	0291359.00126US2

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/D.R./	AA*	US-20010038713	11-08-2001	Kitagawa et al.	
	AB*	US-20020012454-A1	01-31-2002	Liu et al.	
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Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear
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	BB	EP-1143375	10-10-2001	NEC Corporation	
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	BD	WO-01/63560	08-30-2001	Digimask Limited	

Examiner Signature	/David Rashid/	Date Considered	03/10/2009
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. * CITE NO.: Those application(s) which are marked with an asterisk (*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
/D.R./	CA	Weisstein, "Matrix Norm," December 22, 2003, http://mathworld.wolfram.com/MatrixNorm.html (2 pages)	
	CB	Weisstein, "Projective Geometry" December 22, 2003, http://mathworld.wolfram.com/ProjectiveGeometry.html (3 pages).	
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	CE	European Patent Office, Communication Pursuant to Article 96(2) EPC issued for EP04718062.5, 21 September 2007	
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	CG	International Search Report issued for PCT/US04/006604, dated September 2, 2004	
	CH	International Search Report issued for PCT/US04/006614, dated August 26, 2004	
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	CJ	Lanitis et al., "Toward Automatic Simulation of Aging Effects on Face Images," IEEE Transactions on Pattern Analysis and Machine Intelligence, Vol. 24, No. 4 (April 2002), pp. 442-455	
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	CL	Lopez et al., "3D head pose computation from 2D images: templates versus features," IEEE Computer Society, Vol. 3 (October 23, 1995), pp. 599-602	
	CM	Pighin et al., "Synthesizing realistic facial expressions from photographs," Computer Graphics Conference Proceedings, (July 19, 1998), pp. 75-84	

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